



EIA STANDARD

ANSI/EIA-364-69A-2002(R2015)

Approved: March 6, 2002

Reaffirmed: March 27, 2015

TP-69A

Low Level Induction Measurement for Electrical Contacts of Electrical Connectors

EIA-364-69A

(Revision of EIA-364-69)

March 2002



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(From Standards Proposal No. 4830, formulated under the cognizance of the CE-2.0 Committee on EIA National Connector and Socket Standards, and reaffirmed per Standards Proposal No. 5346.05).

Published by

©Electronic Components Industry Association 2015
Standards & Technology Department
2214 Rock Hill Road, Suite 265
Herndon, VA 20170

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CONTENTS

Clause		Page
1	Introduction	1
1.1	Scope	1
1.2	Object	1
1.3	Definitions	1
2	Test resources	1
2.1	Equipment	1
2.2	Fixture	2
3	Test specimen	3
3.1	Description	3
4	Test procedure	3
5	Details to be specified	4
6	Test documentation	5
 Figure		
1	Recommended test frequency range plot as a function of specimen inductance	2
A.1	Test fixture conductors	A-1
A.2	Skin effect versus frequency nomograph	A-3
 Annex		
A	Test fixture (normative)	A-1
B	Guidance to determine the self inductance (informative)	B-1

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